

General Description

The AAT8343 is a low threshold P-channel MOS-FET designed for the battery, cell phone, and PDA markets. Using AnalogicTech's ultra-high-density proprietary TrenchDMOS™ technology, this product demonstrates high power handling and small size.

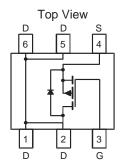
Applications

- Battery Packs
- Battery-Powered Portable Equipment
- Cellular and Cordless Telephones

Features

- Drain-Source Voltage (max): -20V
- Continuous Drain Current¹ (max):
 -4.5A @ 25°C
- Low On-Resistance:
 - 60m Ω @ V_{GS} = -4.5V
 - 110mΩ @ $V_{GS} = -2.5V$

TSOP-6 Package



Absolute Maximum Ratings

 $T_A = 25$ °C, unless otherwise noted.

Symbol	Description		Value	Units	
V _{DS}	Drain-Source Voltage		-20	V	
V_{GS}	Gate-Source Voltage		±12		
	Continuous Drain Current @ T _J = 150°C¹	$T_A = 25$ °C	±4.5		
I _D		$T_A = 70$ °C	±3.6	Α	
I _{DM}	Pulsed Drain Current ²		±16	A	
I _S	Continuous Source Current (Source-Drain Diode) ¹		-1.3		
T _J	Operating Junction Temperature Range		-55 to 150	°C	
T _{STG}	Storage Temperature Range		-55 to 150	°C	

Thermal Characteristics¹

Symbol	Description		Тур	Max	Units	
$R_{\theta JA}$	Junction-to-Ambient Steady State		95	115	°C/W	
$R_{\theta JA2}$	Junction-to-Ambient t<5 Seconds		51	62	°C/W	
$R_{\theta JF}$	Junction-to-Foot		25	30	°C/W	
P _D	Maximum Power Dissipation	T _A = 25°C		2.0	W	
		T _A = 70°C		1.3	VV	

^{1.} Based on thermal dissipation from junction to ambient while mounted on a 1" x 1" PCB with optimized layout. A 5-second pulse on a 1" x 1" PCB approximates testing a device mounted on a large multi-layer PCB as in most applications. $R_{\theta JF} + R_{\theta FA} = R_{\theta JA}$ where the foot thermal reference is defined as the normal solder mounting surface of the device's leads. $R_{\theta JF}$ is guaranteed by design; however, $R_{\theta CA}$ is determined by the PCB design. Actual maximum continuous current is limited by the application's design.

^{2.} Pulse test: Pulse Width = 300µs.



Electrical Characteristics

 $T_J = 25$ °C, unless otherwise noted.

Symbol	Description	Conditions	Min	Тур	Max	Units	
DC Chara	cteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0V$, $I_D = -250\mu A$	-20			V	
R _{DS(ON)}	Drain-Source On-Resistance¹	$V_{GS} = -4.5V, I_D = -4.5A$ $V_{GS} = -2.5V, I_D = -3.3A$		49 85	60 110	mΩ	
I _{D(ON)}	On-State Drain Current ¹	$V_{GS} = -4.5V, V_{DS} = -5V \text{ (pulsed)}$	-16	00	110	Α	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = -250\mu A$	-0.6			V	
I _{GSS}	Gate-Body Leakage Current	$V_{GS} = \pm 12V$, $V_{DS} = 0V$			±100	nA	
I _{DSS}	Drain Source Leakage Current	$V_{GS} = 0V$, $V_{DS} = -20V$			-1	μA	
		$V_{GS} = 0V, V_{DS} = -16V, T_{J} = 70^{\circ}C^{2}$			-5		
g_{fs}	Forward Transconductance ¹	$V_{DS} = -5V, I_{D} = -4.5A$		7		S	
Dynamic	Characteristics ²						
Q_G	Total Gate Charge	$V_{DS} = -10V$, $R_D = 2.2\Omega$, $V_{GS} = -4.5V$		8.5			
Q_{GS}	Gate-Source Charge	$V_{DS} = -10V, R_D = 2.2\Omega, V_{GS} = -4.5V$		1.8		nC	
Q_{GD}	Gate-Drain Charge	$V_{DS} = -10V, R_D = 2.2\Omega, V_{GS} = -4.5V$		2.9		1	
t _{D(ON)}	Turn-On Delay	$V_{DS} = -10V, R_D = 2.2\Omega, V_{GS} = -4.5V, R_G = 6\Omega$		12			
t _R	Turn-On Rise Time	$V_{DS} = -10V, R_D = 2.2\Omega, V_{GS} = -4.5V, R_G = 6\Omega$		32			
t _{D(OFF)}	Turn-Off Delay	$V_{DS} = -10V, R_D = 2.2\Omega, V_{GS} = -4.5V, R_G = 6\Omega$		64		ns	
t _F	Turn-Off Fall Time	$V_{DS} = -10V, R_D = 2.2\Omega, V_{GS} = -4.5V, R_G = 6\Omega$		40			
Source-D	rain Diode Characteristics						
V_{SD}	Source-Drain Forward Voltage ¹	$V_{GS} = 0$, $I_{S} = -4.5A$			-1.3	V	
I _S	Continuous Diode Current ³				-1.3	Α	

^{1.} Pulse test: Pulse Width = 300µs.

^{2.} Guaranteed by design. Not subject to production testing.

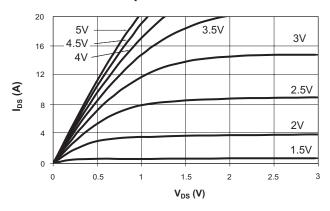
^{3.} Based on thermal dissipation from junction to ambient while mounted on a 1" x 1" PCB with optimized layout. A 5-second pulse on a 1" x 1" PCB approximates testing a device mounted on a large multi-layer PCB as in most applications. $R_{\theta JF} + R_{\theta FA} = R_{\theta JA}$ where the foot thermal reference is defined as the normal solder mounting surface of the device's leads. $R_{\theta JF}$ is guaranteed by design; however, $R_{\theta CA}$ is determined by the PCB design. Actual maximum continuous current is limited by the application's design.



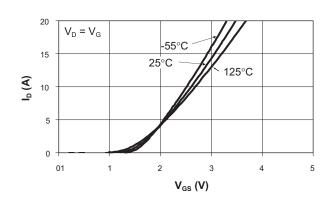
Typical Characteristics

 $T_{.1} = 25^{\circ}$ C, unless otherwise noted.

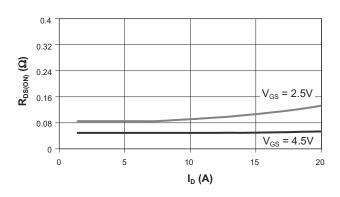
Output Characteristics



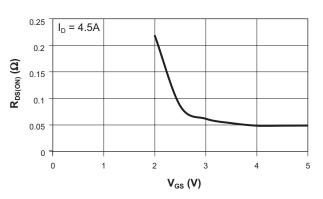
Transfer Characteristics



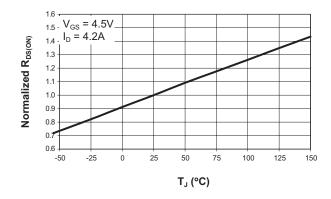
On-Resistance vs. Drain Current



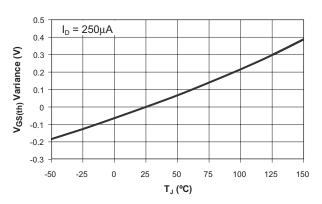
On-Resistance vs. Gate-to-Source Voltage



On-Resistance vs. Junction Temperature



Threshold Voltage

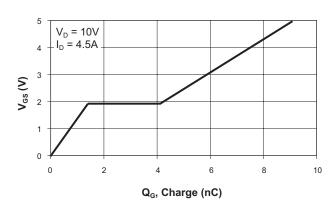




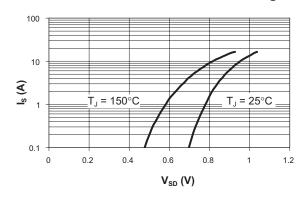
Typical Characteristics

 $T_{\perp} = 25^{\circ}$ C, unless otherwise noted.

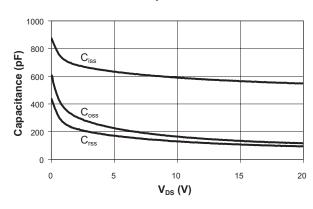
Gate Charge



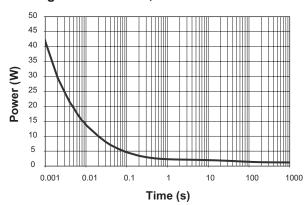
Source-Drain Diode Forward Voltage



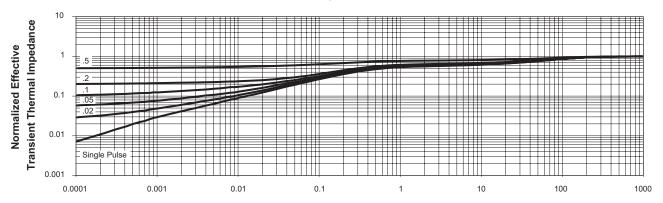
Capacitance



Single Pulse Power, Junction to Ambient



Transient Thermal Response, Junction to Ambient



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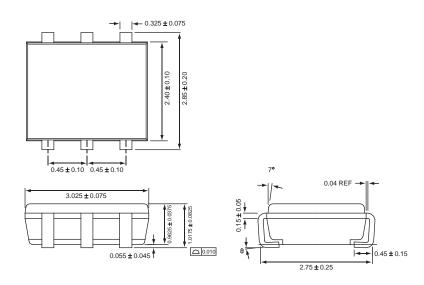


Ordering Information

Package	Marking ¹	Part Number (Tape and Reel) ²
TSOP-6	KEXYY	AAT8343IDU-T1

Package Information

TSOP-6



All dimensions in millimeters.

^{1.} XYY = assembly and date code.

^{2.} Sample stock is generally held on part numbers listed in BOLD.



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